



Support & training



MAX3232 SLLS4100 – JANUARY 2000 – REVISED JUNE 2021

# MAX3232 3-V to 5.5-V Multichannel RS-232 Line Driver and Receiver With ±15-kV ESD Protection

## 1 Features

- RS-232 Bus-terminal esd protection exceeds ±15 kV using human-body model (HBM)
- Meets or exceeds the requirements of TIA/ EIA-232-F and ITU V.28 standards
- Operates with 3-V to 5.5-V V<sub>CC</sub> supply
- Operates up to 250 kbit/s
- Two drivers and two receivers
- Low supply current: 300 µA Typical
- External capacitors: 4 × 0.1 µF
- Accepts 5-V logic input with 3.3-V supply
- Alternative high-speed terminal-compatible devices (1 Mbit/s)
  - SN65C3232 (-40°C to 85°C)
  - SN75C3232 (0°C to 70°C)

## **2** Applications

- Industrial PCs
- Wired networking
- Data center and enterprise networking
- · Battery-powered systems
- PDAs
- Notebooks
- Laptops
- Palmtop PCs
- Hand-held equipment

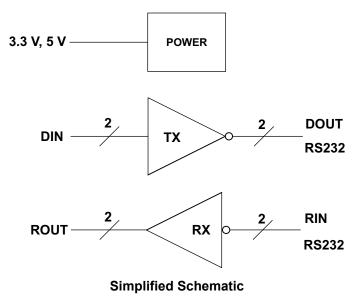
## **3 Description**

The MAX3232 device consists of two line drivers, two line receivers, and a dual charge-pump circuit with ±15-kV ESD protection terminal to terminal (serial-port connection terminals, including GND). The device meets the requirements of TIA/EIA-232-F and provides the electrical interface between an asynchronous communication controller and the serial-port connector. The charge pump and four small external capacitors allow operation from a single 3-V to 5.5-V supply. The devices operate at data signaling rates up to 250 kbit/s and a maximum of 30-V/µs driver output slew rate.

#### **Device Information**

PART NUMBER	PACKAGE <sup>(1)</sup>	BODY SIZE			
MAX3232	SOIC (D) (16)	9.90 mm × 3.91 mm			
	SSOP (DB) (16)	6.20 mm × 5.30 mm			
	SOIC (DW) (16)	10.30 mm × 7.50 mm			
	TSSOP (PW) (16)	5.00 mm × 4.40 mm			

(1) For all available packages, see the orderable addendum at the end of the data sheet.





# **Table of Contents**

1 Features1
2 Applications1
3 Description1
4 Revision History2
5 Pin Configuration and Functions
6 Specifications4
6.1 Absolute Maximum Ratings4
6.2 ESD Ratings4
6.3 Recommended Operating Conditions4
6.4 Thermal Information5
6.5 Electrical Characteristics — Device5
6.6 Electrical Characteristics — Driver
6.7 Electrical Characteristics — Receiver6
6.8 Switching Characteristics6
6.9 Typical Characteristics7
7 Parameter Measurement Information8
8 Detailed Description9
8.1 Overview9

8.2 Functional Block Diagram	. 9
8.3 Feature Description	
8.4 Device Functional Modes	
9 Application and Implementation	11
9.1 Application Information	
9.2 Standard Application	
10 Power Supply Recommendations	12
11 Layout	13
11.1 Layout Guidelines	
11.2 Layout Example	13
12 Device and Documentation Support	
12.1 Receiving Notification of Documentation Updates.	14
12.2 Support Resources	
12.3 Trademarks	
12.4 Electrostatic Discharge Caution	
12.5 Glossary	
13 Mechanical, Packaging, and Orderable	
Information	14

## **4 Revision History**

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

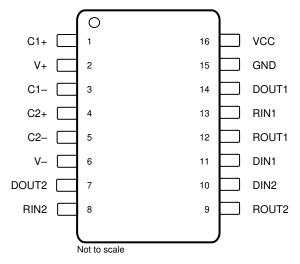
CI	Changes from Revision N (June 2017) to Revision O (June 2021)				
•	Added Applications: Industrial PCs, Wired networking, and Data center and enterprise computing	1			
•	Changed the thermal parameter values for D, DB and PW packages in the Thermal Information table	5			

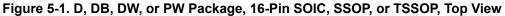
Changes from Revision M (April 2017) to Revision N (June 2017)	Page
Changed the Thermal Information table	
Changes from Revision L (March 2017) to Revision M (April 2017)	Page
Changed From: "±" To: "to" in the V <sub>CC</sub> column of Table 9-1	
Changes from Revision K (January 2015) to Revision L (March 2017)	Page
Changed pin 16 (V <sub>CC</sub> ) in Typical Operating Circuit and Capacitor Values	11
Changes from Revision J (January 2014) to Revision K (January 2015)	Page
<ul> <li>Added Applications, Device Information table, Pin Functions table, ESD Ratin table, Typical Characteristics, Feature Description section, Device Functional Implementation section, Power Supply Recommendations section, Layout se</li> </ul>	Modes, Application and

	Documentation Support section, and Mechanical, Packaging, and Orderable Information section					
С	hanges from Revision I (January 2004) to Revision J (January 2014)	Page				
•	Updated document to new TI data sheet format - no specification changes	1				
•	Deleted Ordering Information table	<b>1</b>				



## **5** Pin Configuration and Functions





#### Table 5-1. Pin Functions

PIN		ТҮРЕ	DESCRIPTION		
NAME	NO.		DESCRIPTION		
C1+	1	—	Positive lead of C1 capacitor		
V+	2	0	Positive charge pump output for storage capacitor only		
C1–	3	_	Negative lead of C1 capacitor		
C2+	4	—	Positive lead of C2 capacitor		
C2–	5	—	Negative lead of C2 capacitor		
V–	6	0	Negative charge pump output for storage capacitor only		
DOUT2	7	0	RS232 line data output (to remote RS232 system)		
DOUT1	14	0	RS232 line data output (to remote RS232 system)		
RIN2	8	I	RS232 line data input (from remote RS232 system)		
RIN1	13	I	RS232 line data input (from remote RS232 system)		
ROUT2	9	0	Logic data output (to UART)		
ROUT1	12	0	Logic data output (to UART)		
DIN2	10	I	Logic data input (from UART)		
DIN1	11	I	Logic data input (from UART)		
GND	15	_	Ground		
V <sub>CC</sub>	16	_	Supply Voltage, Connect to external 3 V to 5.5 V power supply		



## 6 Specifications

## 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

			MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage range <sup>(2)</sup>		-0.3	6	V
V+	Positive output supply voltage range <sup>(2)</sup>		-0.3	7	V
V–	Negative output supply voltage range <sup>(2)</sup>		-7	0.3	V
V+ – V–	Supply voltage difference <sup>(2)</sup>			13	V
V	Input voltage range	Drivers	-0.3	6	V
V		Receivers	-25	25	v
V		Drivers	-13.2	13.2	V
Vo	Output voltage range Receivers		-0.3	V <sub>CC</sub> + 0.3	v
TJ	Operating virtual junction temperature			150	°C
T <sub>stg</sub>	Storage temperature range		-65	150	°C

(1) Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute Maximum Ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If used outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.

(2) All voltages are with respect to network GND.

## 6.2 ESD Ratings

			VALUE	UNIT
V <sub>(ESD)</sub>		Human body model (HBM), per ANSI/ESDA/JEDEC JS-001 RIN , DOUT, and GND pins <sup>(1)</sup>	15000	
	Electrostatic discharge Human body model (HBM), per ANSI/ESDA/JEDEC JS-001 All other pins <sup>(1)</sup>	3000	V	
		Charged device model (CDM), per JEDEC specification JESD22-C101, all $pins^{(2)}$	1000	

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

## 6.3 Recommended Operating Conditions

(see Typical Operating Circuit and Capacitor Values)<sup>(1)</sup>

				MIN	NOM	MAX	UNIT	
V	Supply voltage		V <sub>CC</sub> = 3.3 V	3	3.3	3.6	V	
V <sub>cc</sub>			V <sub>CC</sub> = 5 V	4.5	5	5.5	v	
V <sub>IH</sub>	Driver high-level input voltage DIN	DIN	V <sub>CC</sub> = 3.3 V	2			V	
		V <sub>CC</sub> = 5 V	2.4					
VIL	Driver low-level input voltage	DIN				0.8	V	
V	Driver input voltage	DIN		0		5.5	5.5 V	
VI	Receiver input voltage	RIN		-25		25	v	
T <sub>A</sub>	Operating free-air temperature		MAX3232C	0	70	70	°C	
			MAX3232I	-40		85	C	

(1) Test conditions are C1–C4 = 0.1  $\mu$ F at V<sub>CC</sub> = 3.3 V ± 0.3 V; C1 = 0.047  $\mu$ F, C2–C4 = 0.33  $\mu$ F at V<sub>CC</sub> = 5 V ± 0.5 V.



### 6.4 Thermal Information

		MAX3232					
	THERMAL METRIC <sup>(1)</sup>	(1) SOIC (D) SSOP (DB) SOIC (DW) TSSOP (PW)				UNIT	
	16 PINS						
R <sub>0JA</sub>	Junction-to-ambient thermal resistance	85.9	103.1	66.6	108.2	°C/W	
R <sub>0JC(top)</sub>	Junction-to-case (top) thermal resistance	43.1	49.2	32.4	39.0	°C/W	
R <sub>θJB</sub>	Junction-to-board thermal resistance	44.5	54.8	31.9	54.4	°C/W	
ΨJT	Junction-to-top characterization parameter	10.1	12	8.4	3.3	°C/W	
Ψ <sub>JB</sub>	Junction-to-board characterization parameter	44.1	54.1	31.5	53.8	°C/W	
R <sub>0JC(bot)</sub>	Junction-to-case (bottom) thermal resistance	n/a	n/a	n/a	n/a	°C/W	

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

### 6.5 Electrical Characteristics — Device

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)<sup>(2)</sup> (see Typical Operating Circuit and Capacitor Values)

PARAMETER			MIN	TYP <sup>(1)</sup>	MAX	UNIT	
I <sub>CC</sub>	Supply current	No load,	$V_{CC}$ = 3.3 V to 5 V		0.3	1	mA

(1) All typical values are at  $V_{CC}$  = 3.3 V or  $V_{CC}$  = 5 V, and  $T_A$  = 25°C.

(2) Test conditions are C1–C4 = 0.1  $\mu$ F at V<sub>CC</sub> = 3.3 V ± 0.3 V; C1 = 0.047  $\mu$ F, C2–C4 = 0.33  $\mu$ F at V<sub>CC</sub> = 5 V ± 0.5 V.

### 6.6 Electrical Characteristics — Driver

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)<sup>(3)</sup> (see Typical Operating Circuit and Capacitor Values)

	PARAMETER	TEST CONE	ITIONS	MIN	TYP <sup>(1)</sup>	MAX	UNIT
V <sub>OH</sub>	High-level output voltage	$D_{OUT}$ at $R_L = 3 k\Omega$ to GND,	D <sub>IN</sub> = GND	5	5.4		V
V <sub>OL</sub>	Low-level output voltage	$D_{OUT}$ at $R_L = 3 k\Omega$ to GND,	D <sub>IN</sub> = V <sub>CC</sub>	-5	-5.4		V
I <sub>IH</sub>	High-level input current	V <sub>I</sub> = V <sub>CC</sub>			±0.01	±1	μA
IIL	Low-level input current	V <sub>I</sub> at GND			±0.01	±1	μA
I <sub>OS</sub> <sup>(2)</sup>	Short-circuit output current	V <sub>CC</sub> = 3.6 V	V <sub>O</sub> = 0 V		±35	±60	mA
los (	Short-circuit output current	V <sub>CC</sub> = 5.5 V	V <sub>O</sub> = 0 V		±35	TOO	ША
r <sub>O</sub>	Output resistance	$V_{CC}$ , V+, and V– = 0 V	$V_0 = \pm 2 V$	300	10M		Ω

(1) All typical values are at  $V_{CC}$  = 3.3 V or  $V_{CC}$  = 5 V, and  $T_A$  = 25°C.

(2) Short-circuit durations should be controlled to prevent exceeding the device absolute power dissipation ratings, and not more than one output should be shorted at a time.

(3) Test conditions are C1–C4 = 0.1  $\mu$ F at V<sub>CC</sub> = 3.3 V ± 0.3 V; C1 = 0.047  $\mu$ F, C2–C4 = 0.33  $\mu$ F at V<sub>CC</sub> = 5 V ± 0.5

## 6.7 Electrical Characteristics — Receiver

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)<sup>(2)</sup> (see Typical **Operating Circuit and Capacitor Values)** 

	PARAMETER	TEST CONDITIONS	MIN	TYP <sup>(1)</sup>	MAX	UNIT
V <sub>OH</sub>	High-level output voltage	I <sub>OH</sub> = -1 mA	V <sub>CC</sub> - 0.6	V <sub>CC</sub> – 0.1		V
V <sub>OL</sub>	Low-level output voltage	I <sub>OL</sub> = 1.6 mA			0.4	V
V <sub>IT+</sub> Positive-going input threshold	Positive going input threshold voltage	V <sub>CC</sub> = 3.3 V		1.5	2.4	V
	Positive-going input timeshold voltage	V <sub>CC</sub> = 5 V		1.8	2.4	v
V	Negative-going input threshold voltage	V <sub>CC</sub> = 3.3 V	0.6	1.2		V
V <sub>IT-</sub>	Negative-going input theshold voltage	V <sub>CC</sub> = 5 V	0.8	1.5		v
V <sub>hys</sub>	Input hysteresis (V <sub>IT+</sub> – V <sub>IT–</sub> )			0.3		V
r <sub>l</sub>	Input resistance	$V_1 = \pm 3 V$ to $\pm 25 V$	3	5	7	kΩ

(1)

All typical values are at V<sub>CC</sub> = 3.3 V or V<sub>CC</sub> = 5 V, and T<sub>A</sub> = 25°C. Test conditions are C1–C4 = 0.1  $\mu$ F at V<sub>CC</sub> = 3.3 V ± 0.3 V; C1 = 0.047  $\mu$ F, C2–C4 = 0.33  $\mu$ F at V<sub>CC</sub> = 5 V ± 0.5 V. (2)

## 6.8 Switching Characteristics

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)<sup>(3)</sup> (see Typical **Operating Circuit and Capacitor Values)** 

PARAMETER		TEST C	MIN	TYP <sup>(1)</sup>	MAX	UNIT	
	Maximum data rate	$R_L = 3 k\Omega$ ,	C <sub>L</sub> = 1000 pF	150	250		kbit/s
		One D <sub>OUT</sub> switching, See Figure 7-1		150	200		KDII/S
+	Driver Pulse skew <sup>(2)</sup>	er Pulse skew <sup>(2)</sup> $R_{\rm I} = 3 \ k\Omega \text{ to } 7 \ k\Omega,$ $C_{\rm L} = 150 \ \text{to } 2500 \ \text{pF}$			300		ns
t <sub>sk(p)</sub> Driver Pulse skew <sup>(2)</sup>		$ X_{L} = 5 K_{22} to 7 K_{22},$	See Figure 7-2		300		115
SR(tr) Slew rate, transition region	Slew rate, transition region	$R_L = 3 k\Omega$ to 7 k $\Omega$ ,	C <sub>L</sub> = 150 to 1000 pF	6	30		V/µs
Sr(u)	(see Figure 7-1)	V <sub>CC</sub> = 5 V	C <sub>L</sub> = 150 to 2500 pF	4		30	v/µs
t <sub>PLH®)</sub>	Propagation delay time, low- to high- level output	-C <sub>1</sub> = 150 pF			300		
t <sub>PHL®)</sub>	Propagation delay time, high- to low- level output	-o 130 pr		300		ns	
t <sub>sk(p)</sub>	Receiver Pulse skew <sup>(3)</sup>				300		

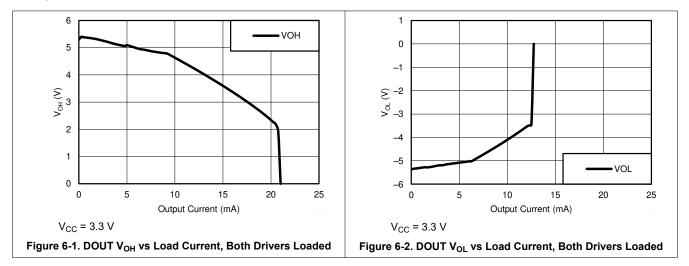
All typical values are at V\_{CC} = 3.3 V or V\_{CC} = 5 V, and T\_A = 25°C. (1)

(2)

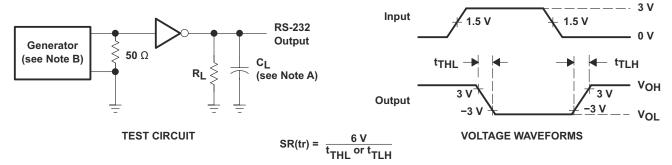
Pulse skew is defined as  $|t_{PLH} - t_{PHL}|$  of each channel of the same device. Test conditions are C1–C4 = 0.1 µF at V<sub>CC</sub> = 3.3 V ± 0.3 V; C1 = 0.047 µF, C2–C4 = 0.33 µF at V<sub>CC</sub> = 5 V ± 0.5 V. (3)



## 6.9 Typical Characteristics



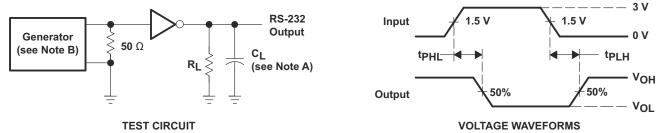
## 7 Parameter Measurement Information



A.  $C_L$  includes probe and jig capacitance.

B. The pulse generator has the following characteristics: PRR = 250 kbit/s,  $Z_0$  = 50  $\Omega$ , 50% duty cycle,  $t_r \le 10$  ns,  $t_f \le 10$  ns.

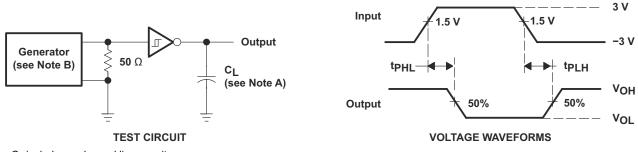
#### Figure 7-1. Driver Slew Rate



A. C<sub>L</sub> includes probe and jig capacitance.

B. The pulse generator has the following characteristics: PRR = 250 kbit/s,  $Z_0$  = 50  $\Omega$ , 50% duty cycle,  $t_r \le 10$  ns,  $t_f \le 10$  ns.

#### Figure 7-2. Driver Pulse Skew



A. C<sub>L</sub> includes probe and jig capacitance.

B. The pulse generator has the following characteristics:  $Z_0 = 50 \Omega$ , 50% duty cycle,  $t_r \le 10 \text{ ns}$ .

### Figure 7-3. Receiver Propagation Delay Times

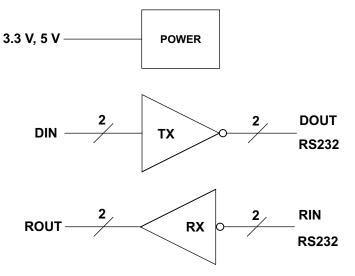


## 8 Detailed Description

### 8.1 Overview

The MAX3232 device consists of two line drivers, two line receivers, and a dual charge-pump circuit with ±15-kV ESD protection terminal to terminal (serial-port connection terminals, including GND). The device meets the requirements of TIA/EIA-232-F and provides the electrical interface between an asynchronous communication controller and the serial-port connector. The charge pump and four small external capacitors allow operation from a single 3-V to 5.5-V supply. The device operates at data signaling rates up to 250 kbit/s and a maximum of 30-V/µs driver output slew rate. Outputs are protected against shorts to ground.

### 8.2 Functional Block Diagram



### 8.3 Feature Description

### 8.3.1 Power

The power block increases, inverts, and regulates voltage at V+ and V- pins using a charge pump that requires four external capacitors.

#### 8.3.2 RS232 Driver

Two drivers interface standard logic level to RS232 levels. Both DIN inputs must be valid high or low.

### 8.3.3 RS232 Receiver

Two receivers interface RS232 levels to standard logic levels. An open input will result in a high output on ROUT. Each RIN input includes an internal standard RS232 load.



## 8.4 Device Functional Modes

## Table 8-1. Each Driver<sup>(1)</sup>

INPUT DIN	OUTPUT DOUT
L	Н
Н	L

(1) H = high level, L = low level

Table 8-2. Each Receiver <sup>(1)</sup>							
INPUT OUTPUT RIN ROUT							
L	Н						
н	L						
Open	Н						

(1) H = high level, L = low level, Open = input disconnected or connected driver off

### 8.4.1 $V_{CC}$ powered by 3 V to 5.5 V

The device will be in normal operation.

### 8.4.2 V<sub>CC</sub> unpowered, V<sub>CC</sub> = 0 V

When MAX3232 is unpowered, it can be safely connected to an active remote RS232 device.



## 9 Application and Implementation

#### Note

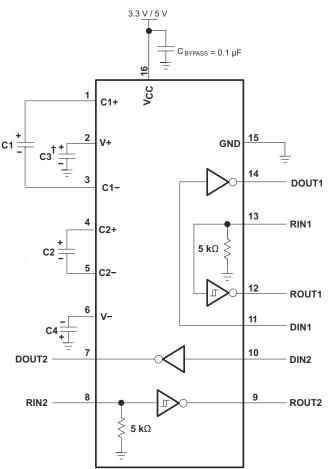
Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

### 9.1 Application Information

For proper operation, add capacitors as shown in Typical Operating Circuit and Capacitor Values.

#### 9.2 Standard Application

ROUT and DIN connect to UART or general purpose logic lines. RIN and DOUT lines connect to a RS232 connector or cable.



 $\dagger$  C3 can be connected to V<sub>CC</sub> or GND.

- A. Resistor values shown are nominal.
- B. Nonpolarized ceramic capacitors are acceptable. If polarized tantalum or electrolytic capacitors are used, they should be connected as shown.

### Figure 9-1. Typical Operating Circuit and Capacitor Values



### 9.2.1 Design Requirements

- Recommended V<sub>CC</sub> is 3.3 V or 5 V. 3 V to 5.5 V is also possible
- Maximum recommended bit rate is 250 kbit/s.

Table 3-1. VCC vs Capacitor values								
Vcc	C1	C2, C3, C4						
3.3 V ± 0.3 V	0.1 µF	0.1 µF						
5 V ± 0.5 V	0.047 µF	0.33 µF						
3 V to 5.5 V	0.1 µF	0.47 µF						

### Table 9-1. V<sub>CC</sub> vs Capacitor Values

### 9.2.2 Detailed Design Procedure

- All DIN, FORCEOFF and FORCEON inputs must be connected to valid low or high logic levels.
- Select capacitor values based on VCC level for best performance.

#### 9.2.3 Application Curves

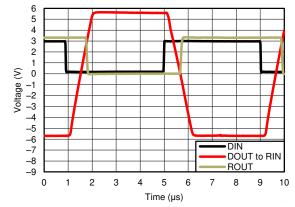




Figure 9-2. 250 kbit/s Driver to Receiver Loopback Timing Waveform

## **10 Power Supply Recommendations**

 $V_{CC}$  should be between 3 V and 5.5 V. Charge pump capacitors should be chosen using table in Typical Operating Circuit and Capacitor Values.



# 11 Layout

### **11.1 Layout Guidelines**

Keep the external capacitor traces short. This is more important on C1 and C2 nodes that have the fastest rise and fall times.

### 11.2 Layout Example

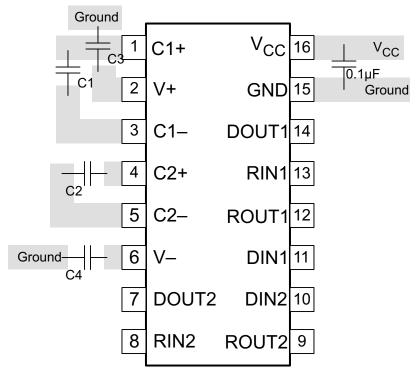


Figure 11-1. Layout Diagram



## 12 Device and Documentation Support

### **12.1 Receiving Notification of Documentation Updates**

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

### **12.2 Support Resources**

TI E2E<sup>™</sup> support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

#### 12.3 Trademarks

TI E2E<sup>™</sup> is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

#### 12.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

### 12.5 Glossary

TI Glossary This glossary lists and explains terms, acronyms, and definitions.

## 13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical packaging and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser based versions of this data sheet, refer to the left hand navigation.



## PACKAGING INFORMATION

Orderable part number	Status	Material type	Package   Pins	Package qty   Carrier	<b>RoHS</b> (3)	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking
P	(1)	(2)			(3)	(4)	(5)		(6)
MAX3232CD	Obsolete	Production	SOIC (D)   16	-	-	Call TI	Call TI	0 to 70	MAX3232C
MAX3232CDB	Obsolete	Production	SSOP (DB)   16	-	-	Call TI	Call TI	0 to 70	MA3232C
MAX3232CDBR	Active	Production	SSOP (DB)   16	2000   LARGE T&R	Yes	NIPDAU   NIPDAU	Level-1-260C-UNLIM	0 to 70	MA3232C
MAX3232CDR	Active	Production	SOIC (D)   16	2500   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	MAX3232C
MAX3232CDW	Obsolete	Production	SOIC (DW)   16	-	-	Call TI	Call TI	0 to 70	MAX3232C
MAX3232CDWR	Obsolete	Production	SOIC (DW)   16	-	-	Call TI	Call TI	0 to 70	MAX3232C
MAX3232CPW	Obsolete	Production	TSSOP (PW)   16	-	-	Call TI	Call TI	0 to 70	MA3232C
MAX3232CPWR	Active	Production	TSSOP (PW)   16	2000   LARGE T&R	Yes	NIPDAU   SN	Level-1-260C-UNLIM	0 to 70	MA3232C
MAX3232CPWRG4	Active	Production	TSSOP (PW)   16	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	MA3232C
MAX3232ID	Obsolete	Production	SOIC (D)   16	-	-	Call TI	Call TI	-40 to 85	MAX3232I
MAX3232IDBR	Active	Production	SSOP (DB)   16	2000   LARGE T&R	Yes	NIPDAU   NIPDAU	Level-1-260C-UNLIM	-40 to 85	MB3232I
MAX3232IDRG4	Obsolete	Production	SOIC (D)   16	-	-	Call TI	Call TI	-40 to 85	MAX3232I
MAX3232IDW	Obsolete	Production	SOIC (DW)   16	-	-	Call TI	Call TI	-40 to 85	MAX3232I
MAX3232IDWR	Active	Production	SOIC (DW)   16	2000   LARGE T&R	Yes	NIPDAU   SN	Level-1-260C-UNLIM	-40 to 85	MAX3232I
MAX3232IPW	Obsolete	Production	TSSOP (PW)   16	-	-	Call TI	Call TI	-40 to 85	MB3232I
MAX3232IPWR	Active	Production	TSSOP (PW)   16	2000   LARGE T&R	Yes	NIPDAU   SN	Level-1-260C-UNLIM	-40 to 85	MB3232I
MAX3232IPWRG4	Active	Production	TSSOP (PW)   16	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	MB3232I

<sup>(1)</sup> **Status:** For more details on status, see our product life cycle.

<sup>(2)</sup> **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.



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# PACKAGE OPTION ADDENDUM

<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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#### OTHER QUALIFIED VERSIONS OF MAX3232 :

Enhanced Product : MAX3232-EP

NOTE: Qualified Version Definitions:

• Enhanced Product - Supports Defense, Aerospace and Medical Applications

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NSTRUMENTS

### TAPE AND REEL INFORMATION





#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
MAX3232CDBR	SSOP	DB	16	2000	330.0	16.4	8.35	6.6	2.4	12.0	16.0	Q1
MAX3232CDR	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
MAX3232CPWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
MAX3232CPWRG4	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
MAX3232IDBR	SSOP	DB	16	2000	330.0	16.4	8.35	6.6	2.4	12.0	16.0	Q1
MAX3232IDWR	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1
MAX3232IPWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
MAX3232IPWRG4	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
MAX3232IPWRG4	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1



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# PACKAGE MATERIALS INFORMATION

3-May-2025



Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
MAX3232CDBR	SSOP	DB	16	2000	356.0	356.0	35.0
MAX3232CDR	SOIC	D	16	2500	340.5	336.1	32.0
MAX3232CPWR	TSSOP	PW	16	2000	356.0	356.0	35.0
MAX3232CPWRG4	TSSOP	PW	16	2000	356.0	356.0	35.0
MAX3232IDBR	SSOP	DB	16	2000	356.0	356.0	35.0
MAX3232IDWR	SOIC	DW	16	2000	350.0	350.0	43.0
MAX3232IPWR	TSSOP	PW	16	2000	356.0	356.0	35.0
MAX3232IPWRG4	TSSOP	PW	16	2000	356.0	356.0	35.0
MAX3232IPWRG4	TSSOP	PW	16	2000	356.0	356.0	35.0

# **DW 16**

# **GENERIC PACKAGE VIEW**

# SOIC - 2.65 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT

7.5 x 10.3, 1.27 mm pitch

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.





# **DW0016A**



# **PACKAGE OUTLINE**

SOIC - 2.65 mm max height

SOIC



#### NOTES:

- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
  This drawing is subject to change without notice.
  This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm, per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm, per side.
- 5. Reference JEDEC registration MS-013.



# DW0016A

# **EXAMPLE BOARD LAYOUT**

# SOIC - 2.65 mm max height

SOIC



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



# DW0016A

# **EXAMPLE STENCIL DESIGN**

# SOIC - 2.65 mm max height

SOIC



NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

9. Board assembly site may have different recommendations for stencil design.



D (R-PDSO-G16)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.



# **PW0016A**



# **PACKAGE OUTLINE**

# TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



# PW0016A

# **EXAMPLE BOARD LAYOUT**

# TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



# PW0016A

# **EXAMPLE STENCIL DESIGN**

# TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

9. Board assembly site may have different recommendations for stencil design.



<sup>8.</sup> Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

# **DB0016A**



# **PACKAGE OUTLINE**

# SSOP - 2 mm max height

SMALL OUTLINE PACKAGE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not

- exceed 0.15 mm per side. 4. Reference JEDEC registration MO-150.



# DB0016A

# **EXAMPLE BOARD LAYOUT**

# SSOP - 2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

5. Publication IPC-7351 may have alternate designs.

6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

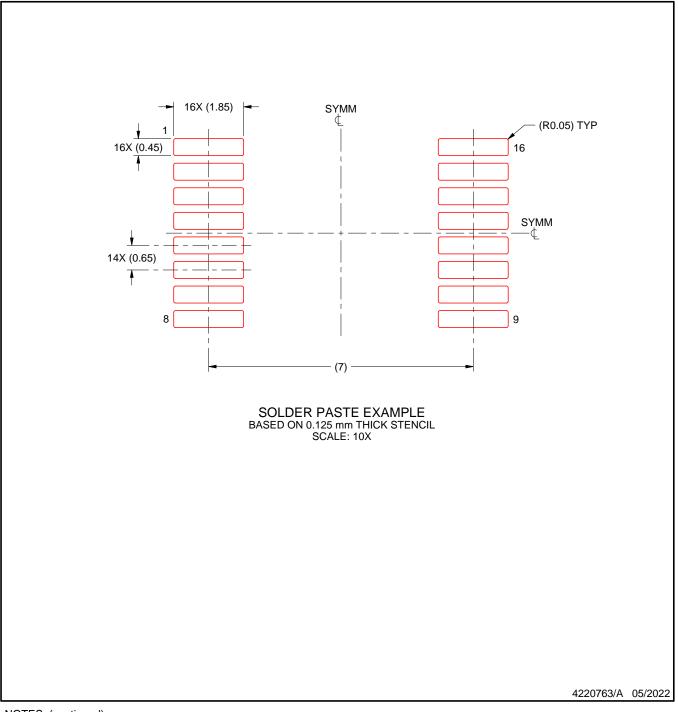


# DB0016A

# **EXAMPLE STENCIL DESIGN**

# SSOP - 2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

8. Board assembly site may have different recommendations for stencil design.



<sup>7.</sup> Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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